

### FDN336P

# Single P-Channel 2.5V Specified PowerTrench™ MOSFET

### **General Description**

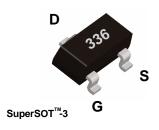
This P-Channel 2.5V specified MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain low gate charge for superior switching performance.

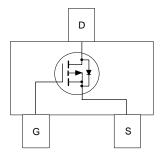
These devices are well suited for portable electronics applications: load switching and power management, battery charging circuits, and DC/DC conversion.

#### **Features**

- -1.3 A, -20 V.  $R_{DS(ON)} = 0.20 \Omega$  @  $V_{GS} = -4.5 \text{ V}$  $R_{DS(ON)} = 0.27 \Omega$  @  $V_{GS} = -2.5 \text{ V}$ .
- Low gate charge (3.6 nC typical).
- High performance trench technology for extremely low R<sub>DS/ONI</sub>.
- High power version of industry standard SOT-23 package.
   Identical pin out to SOT-23 with 30% higher power handling capability.







## **Absolute Maximum Ratings** $T_A = 25^{\circ}C$ unless other wise noted

Symbol	Parameter	FDN336P	Units
V <sub>DSS</sub>	Drain-Source Voltage	-20	V
/ <sub>GSS</sub>	Gate-Source Voltage	±8	V
D	Drain Current - Continuous	-1.3	A
	- Pulsed	-10	
$P_{D}$	Maximum Power Dissipation (Note 1a)	0.5	W
	(Note 1b	0.46	
J,T <sub>STG</sub>	Operating and Storage Temperature Range	-55 to +150	°C
THERMA	L CHARACTERISTICS		
R <sub>eya</sub>	Thermal Resistance, Junction-to-Ambient (Note 1a)	250	°C/W
₹ <sub>euc</sub>	Thermal Resistance, Junction-to-Case (Note 1)	75	°C/W

Symbol	Parameter	Conditions		Min	Тур	Max	Units
OFF CHAR	ACTERISTICS						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, \ I_{D} = -250 \mu\text{A}$		-20			V
$\Delta BV_{DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient	$I_D = -250 \mu\text{A}$ , Referenced to 25 °C			-16		mV /°C
DSS	Zero Gate Voltage Drain Current	$V_{DS} = -16 \text{ V}, \ V_{GS} = 0 \text{ V}$				-1	μA
			T <sub>J</sub> = 55°C			-10	μΑ
GSSF	Gate - Body Leakage, Forward	$V_{GS} = 8 \text{ V}, V_{DS} = 0 \text{ V}$	•			100	nA
GSSR	Gate - Body Leakage, Reverse	$V_{GS} = -8 \text{ V}, V_{DS} = 0 \text{ V}$				-100	nA
ON CHARA	CTERISTICS (Note 2)						
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \mu\text{A}$		-0.4	-0.9	-1.5	V
$\Delta V_{GS(th)}/\Delta T_{J}$	Gate Threshold Voltage Temp. Coefficient	$I_D = -250 \mu\text{A}$ , Referenced to	$I_D = -250 \mu\text{A}$ , Referenced to 25 °C		3		mV /°C
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	$V_{GS} = -4.5 \text{ V}, I_{D} = -1.3 \text{ A}$			0.122	0.2	Ω
-(- /			T <sub>J</sub> =125°C		0.18	0.32	
		$V_{GS} = -2.5 \text{ V}, I_D = -1.1 \text{ A}$	•		0.19	0.27	
D(ON)	On-State Drain Current	$V_{GS} = -4.5 \text{ V}, \ V_{DS} = -5 \text{ V}$		-5			Α
) <sub>FS</sub>	Forward Transconductance	$V_{DS} = -4.5 \text{ V}, I_{D} = -2 \text{ A}$			4		S
OYNAMIC C	HARACTERISTICS						
C <sub>iss</sub>	Input Capacitance	$V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V},$ $f = 1.0 \text{ MHz}$			330		pF
Coss	Output Capacitance				80		pF
C <sub>rss</sub>	Reverse Transfer Capacitance				35		pF
SWITCHING	CHARACTERISTICS (Note 2)						
D(on)	Turn - On Delay Time	$V_{DD} = -5 \text{ V}, \ I_{D} = -0.5 \text{ A},$ $V_{GS} = -4.5 \text{ V}, \ R_{GEN} = 6 \Omega$			7	15	ns
r	Turn - On Rise Time				12	22	ns
D(off)	Turn - Off Delay Time				16	26	ns
f	Turn - Off Fall Time				5	12	ns
$Q_{g}$	Total Gate Charge	$V_{DS} = -10 \text{ V}, I_{D} = -2 \text{ A},$ $V_{GS} = -4.5 \text{ V}$			3.6	5	nC
$Q_{gs}$	Gate-Source Charge				0.8		nC
$Q_{gd}$	Gate-Drain Charge				0.7		nC
DRAIN-SOU	RCE DIODE CHARACTERISTICS AND MAX	(IMUM RATINGS					
S	Maximum Continuous Drain-Source Diode Fo	ximum Continuous Drain-Source Diode Forward Current				-0.42	Α
$V_{SD}$	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = -0.42 \text{ A}$ (No	te)		-0.7	-1.2	V

<sup>1.</sup> R<sub>a.u.</sub> is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R<sub>a.c.</sub> is guaranteed by design while  $\boldsymbol{R}_{\scriptscriptstyle{\theta CA}}$  is determined by the user's board design.



a. 250°C/W when mounted on a 0.02 in² pad of 2oz Cu.



b. 270°C/W when mounted on a 0.001 in² pad of 2oz Cu.

Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width  $\leq$  300 $\mu$ s, Duty Cycle  $\leq$  2.0%.

### **Typical Electrical Characteristics**

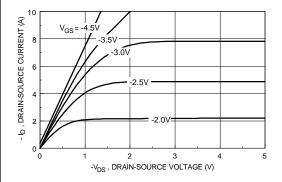


Figure 1. On-Region Characteristics.

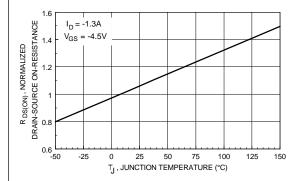


Figure 3. On-Resistance Variation with Temperature.

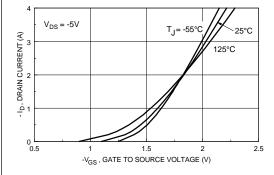


Figure 5. Transfer Characteristics.

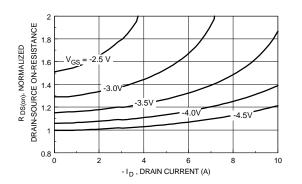


Figure 2. On-Resistance Variation with Drain Current and Gate

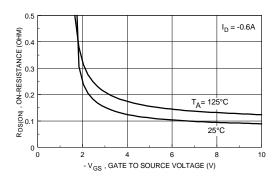


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

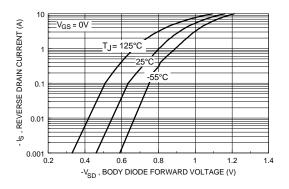


Figure 6. Body Diode Forward Voltage

Variation with Source

Current

and Temperature.

### **Typical Electrical Characteristics** (continued)

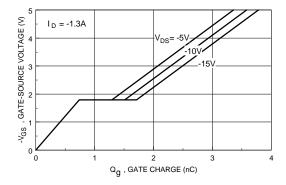


Figure 7. Gate Charge Characteristics.

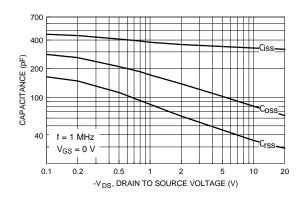


Figure 8. Capacitance Characteristics.

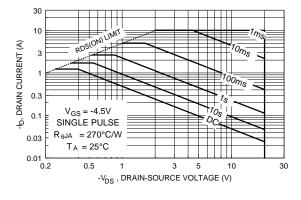


Figure 9. Maximum Safe Operating Area.

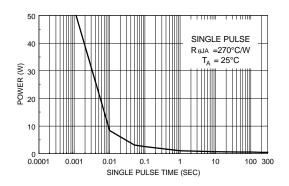


Figure 10. Single Pulse Maximum Power Dissipation.

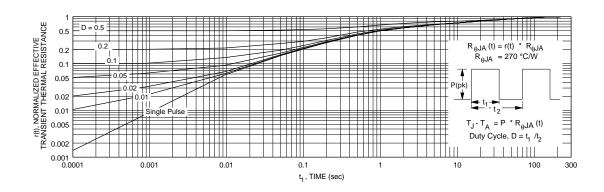


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.

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